

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10559915	RUIGROK ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Alain L Bashore	1792	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
427	547,	12-19-08	ab
29	603.08; 603.14	12-19-08	ab

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (attached)	12-18-08	ab
eDAN inventor search	12-18-08	ab
previous search updated	6-8-09	ab
EAST search (updated)	12/5/2009	ML

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/M. C. L./  
Examiner. Art Unit 1792

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